BSP110

N-channel enhancement mode field-effect transistor

Rev. 03 — 26 July 2000 **Product specification**

1. Description

N-channel enhancement mode field-effect transistor in a plastic package using TrenchMOS™[1] technology.

Product availability:

BSP110 in SOT223.

2. Features

- TrenchMOS™ technology
- Very fast switching
- Logic level compatible
- Surface mount package.

3. Applications

- Relay driver
- High speed line driver
- Logic level translator.

4. Pinning information

Table 1: Pinning - SOT223, simplified outline and symbol

Pin	Description	Simplified outline	Symbol
1	gate (g)	SOT223	N-channel MOSFET
2	drain (d)		
3	source (s)		
4	drain (d)		

1. TrenchMOS is a trademark of Royal Philips Electronics.

5. Quick reference data

Table 2: Quick reference data

Symbol	Parameter	Conditions	Typ	Max	Unit
V_{DS}	drain-source voltage (DC)	T_j = 25 to 150 °C	–	100	V
I_D	drain current (DC)	T_{sp} = 25 °C; V_{GS} = 5 V	–	520	mA
P_{tot}	total power dissipation	T_{sp} = 25 °C	–	6.25	W
T_j	junction temperature		–	150	°C
R_{DSon}	drain-source on-state resistance	V_{GS} = 5 V; I_D = 150 mA	5	10	Ω

6. Limiting values

Table 3: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage (DC)	T_j = 25 to 150 °C	–	100	V
V_{DGR}	drain-gate voltage (DC)	T_j = 25 to 150 °C; R_{GS} = 20 kΩ	–	100	V
V_{GS}	gate-source voltage (DC)		–	±20	V
I_D	drain current (DC)	T_{sp} = 25 °C; V_{GS} = 5 V; Figure 2 and 3	–	520	mA
		T_{sp} = 100 °C; V_{GS} = 5 V; Figure 2	–	330	mA
I_{DM}	peak drain current	T_{sp} = 25 °C; pulsed; $t_p \leq$ 10 µs; Figure 3	–	2	A
P_{tot}	total power dissipation	T_{sp} = 25 °C; Figure 1	–	6.25	W
T_{stg}	storage temperature		–65	+150	°C
T_j	operating junction temperature		–65	+150	°C
Source-drain diode					
I_S	source (diode forward) current (DC)	T_{sp} = 25 °C	–	520	mA
I_{SM}	peak source (diode forward) current	T_{sp} = 25 °C; pulsed; $t_p \leq$ 10 µs	–	2	A

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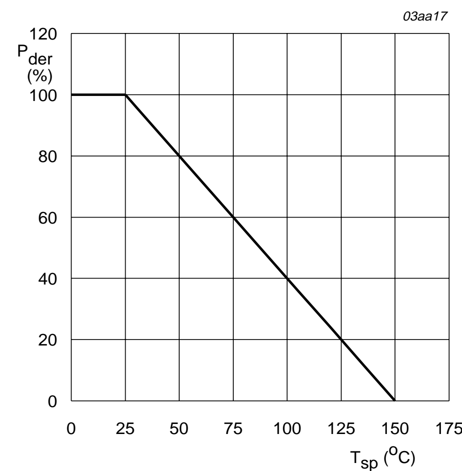
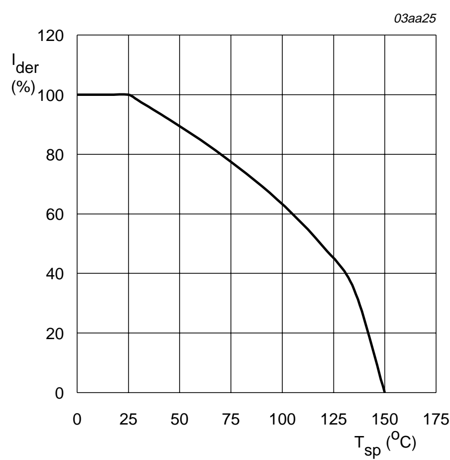


$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

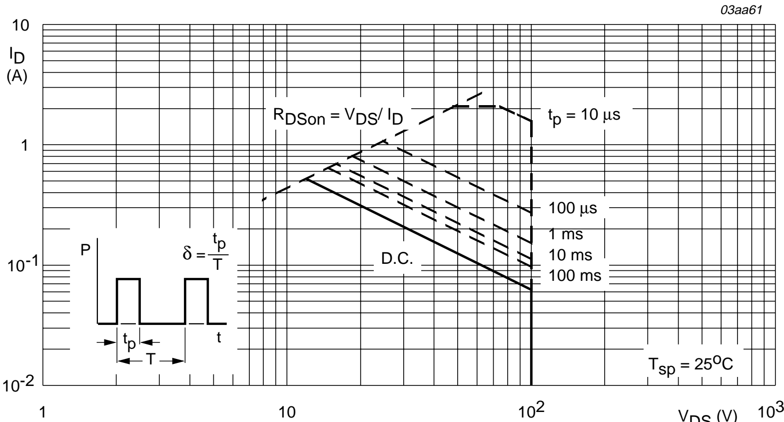
Fig 1. Normalized total power dissipation as a function of solder point temperature.



$V_{GS} \geq 5$ V

$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of solder point temperature.



$T_{sp} = 25$ °C; I_{DM} is single pulse.

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

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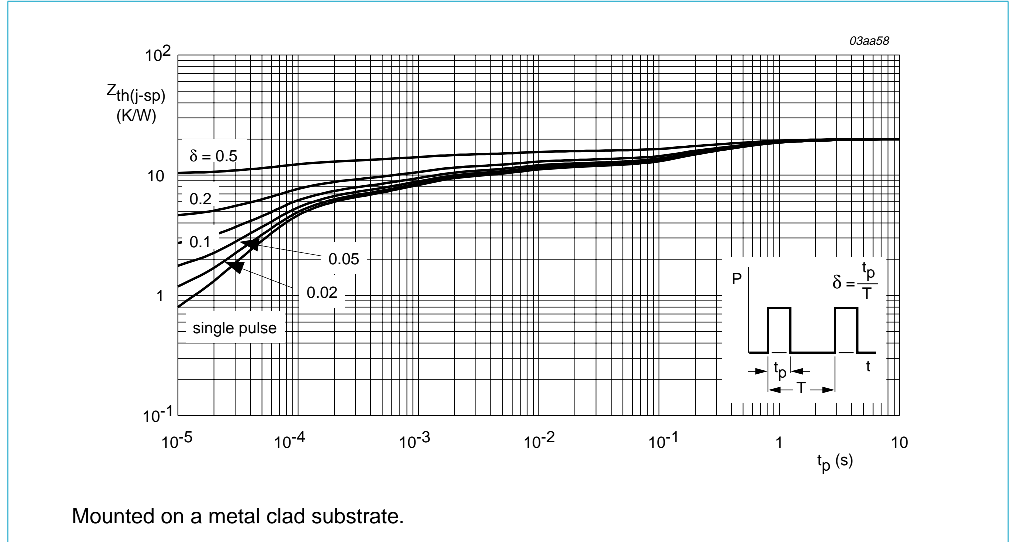
7. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Value	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	mounted on a metal clad substrate; Figure 4	20	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	mounted on a printed circuit board; minimum footprint	150	K/W

7.1 Transient thermal impedance



Mounted on a metal clad substrate.

Fig 4. Transient thermal impedance from junction to solder point as a function of pulse duration.

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8. Characteristics

Table 5: Characteristics

T_j = 25 °C unless otherwise specified

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	I_D = 10 µA; V_{GS} = 0 V				
		T_j = 25 °C	100	130	–	V
		T_j = –55 °C	89	–	–	V
$V_{GS(th)}$	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS}; Figure 9				
		T_j = 25 °C	1	2	–	V
		T_j = 150 °C	0.6	–	–	V
		T_j = –55 °C	–	–	3.5	V
I_{DSS}	drain-source leakage current	V_{DS} = 60 V; V_{GS} = 0 V				
		T_j = 25 °C	–	0.01	1.0	µA
		T_j = 150 °C	–	–	10	µA
I_{GSS}	gate-source leakage current	V_{GS} = ±20 V; V_{DS} = 0 V	–	10	100	nA
R_{DSon}	drain-source on-state resistance	V_{GS} = 5 V; I_D = 150 mA; Figure 7 and 8				
		T_j = 25 °C	–	5	10	Ω
		T_j = 150 °C	–	–	23	Ω
Dynamic characteristics						
g_{fs}	forward transconductance	V_{DS} = 5 V; I_D = 175 mA; Figure 11	–	350	–	mS
C_{iss}	input capacitance	V_{GS} = 0 V; V_{DS} = 10 V; f = 1 MHz; Figure 12	–	25	40	pF
C_{oss}	output capacitance		–	8.5	15	pF
C_{rss}	reverse transfer capacitance		–	5	10	pF
t_{on}	turn-on time	V_{DD} = 50 V; R_D = 250 Ω; V_{GS} = 10 V; R_G = 50 Ω; R_{GS} = 50 Ω	–	3	10	ns
t_{off}	turn-off time		–	12	15	ns
Source-drain diode						
V_{SD}	source-drain (diode forward) voltage	I_S = 300 mA; V_{GS} = 0 V; Figure 13	–	0.95	1.5	V
t_{rr}	reverse recovery time	I_S = 300 mA; dI_S/dt = –100 A/µs; V_{GS} = 0 V; V_{DS} = 25 V	–	30	–	ns
Q_r	recovered charge		–	30	–	nC

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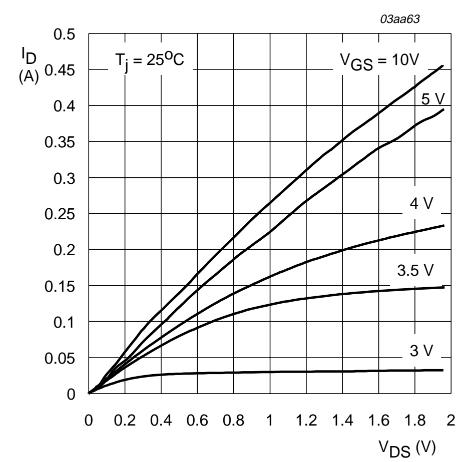
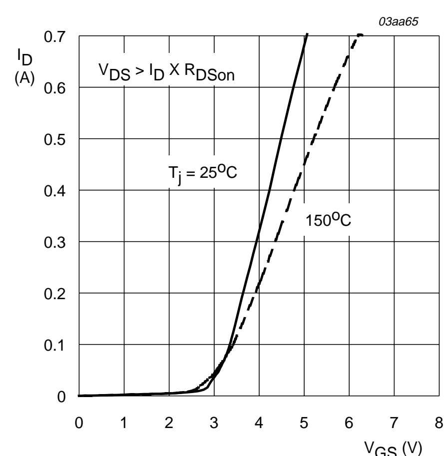


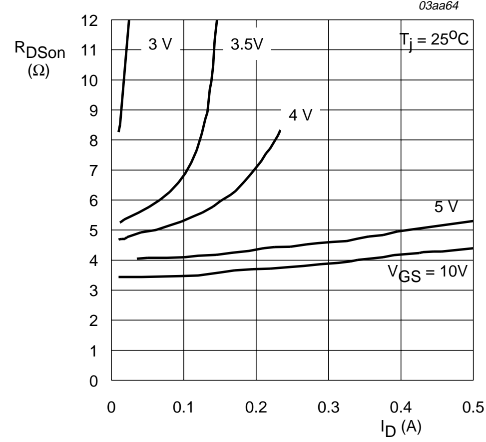
$T_j = 25\ °C$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



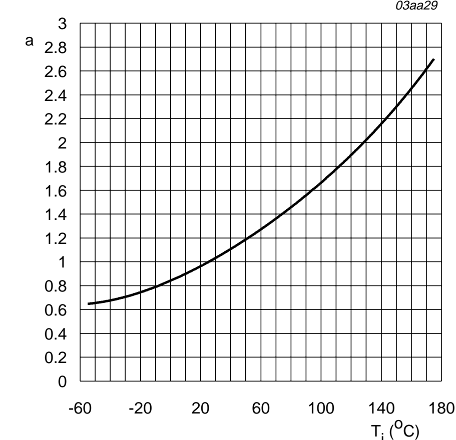
$T_j = 25\ °C$ and $150\ °C$; $V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



$T_j = 25\ °C$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values.



$$a = \frac{R_{DSon}}{R_{DSon(25°C)}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.

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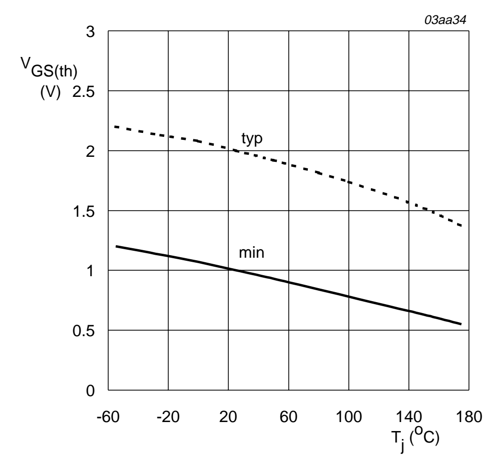
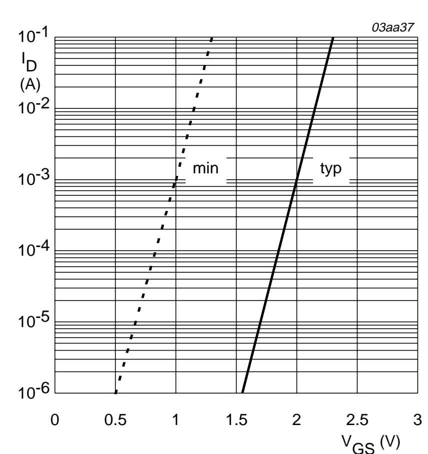


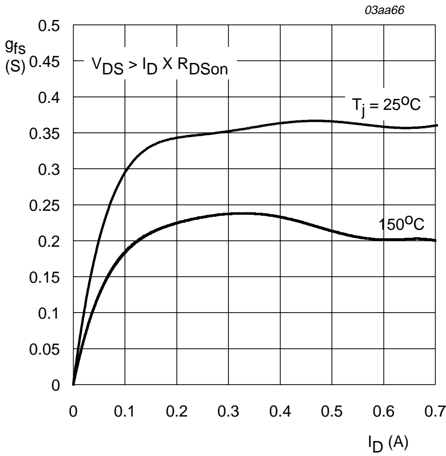
I_D = 1 mA; V_{DS} = V_{GS}

Fig 9. Gate-source threshold voltage as a function of junction temperature.



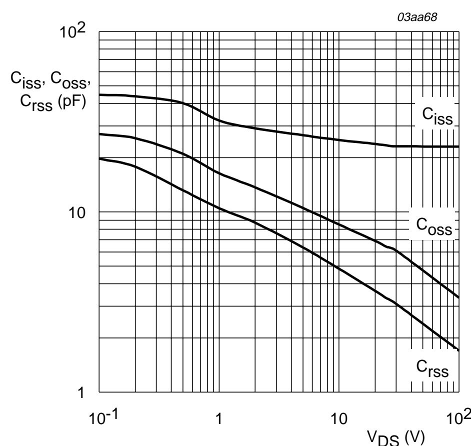
T_j = 25 °C; V_{DS} = 5 V

Fig 10. Sub-threshold drain current as a function of gate-source voltage.



T_j = 25 °C and 150 °C; $V_{DS} > I_D \times R_{DSon}$

Fig 11. Forward transconductance as a function of drain current; typical values.



V_{GS} = 0 V; f = 1 MHz

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.

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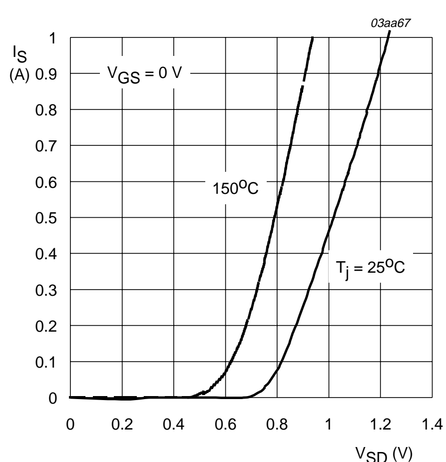

T_j = 25 °C and 150 °C; V_{GS} = 0 V

Fig 13. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.

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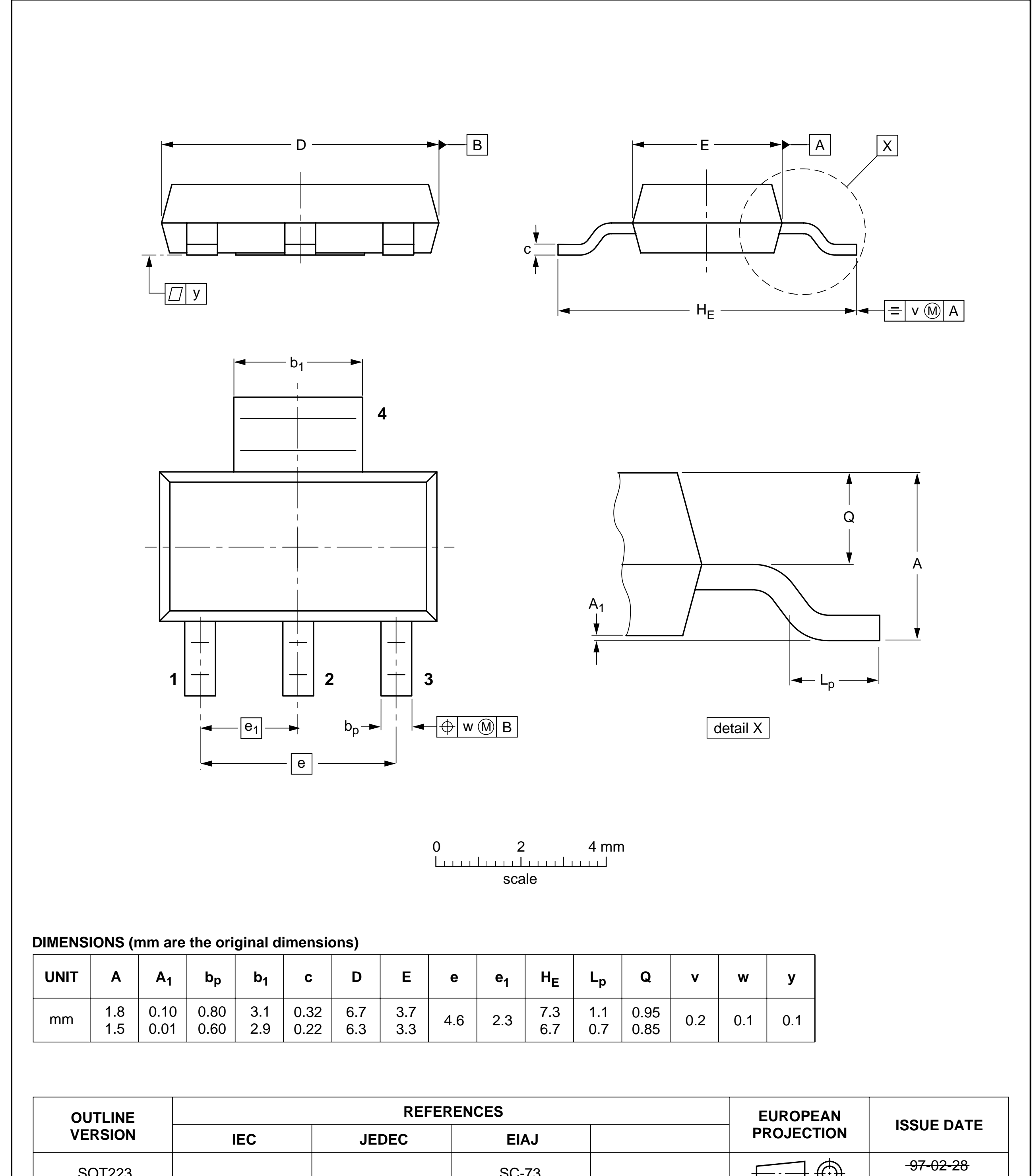
9. Package outline

Plastic surface mounted package; collector pad for good heat transfer; 4 leads **SOT223**



DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1	b_p	b_1	c	D	E	e	e_1	H_E	L_p	Q	v	w	y
mm	1.8 1.5	0.10 0.01	0.80 0.60	3.1 2.9	0.32 0.22	6.7 6.3	3.7 3.3	4.6	2.3	7.3 6.7	1.1 0.7	0.95 0.85	0.2	0.1	0.1

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT223			SC-73			~~97-02-28~~ 99-09-13

Fig 14. SOT223.

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10. Revision history

Table 6: Revision history

Rev	Date	CPCN	Description
03	20000726	HZG303	**Product specification; third version; supersedes BSP110_CNV_2 of 970623.** Converted from VDMOS (Nijmegen) to TrenchMOS™ technology (Hazel Grove).
02	19970623	-	**Product specification; second version.**
01	19901031	-	**Product specification; initial version.**

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11. Data sheet status

Datasheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

[1] Please consult the most recently issued data sheet before initiating or completing a design.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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Date of release: 26 July 2000 **Document order number: 9397 750 07256**